Docket No.

192520US2

- IN RE APPLICATION OF: Hayashi OTSUKI, et al.

SERIAL NO: 09/594,479

FILED:

June 14, 2000

FOR:

PARTICLE-MEASURING SYSTEM AND PARTICLE-MEASURING METHOD

ASSISTANT COMMISSIONER FOR PATENTS WASHINGTON, D.C. 20231

SIR:

Transmitted herewith is an Amendment After Final in the above-identified application.

No additional fee is required

□ Small entity status of this application under 37 C.F.R. §1.9 and §1.27 is claimed.

■ Additional documents filed herewith:

Marked-up Copy of Amendment

RECEIVED

JUL 24 2002

TECHNOLOGY CENTER 2800

"RESPONSE UNDER 37 CFR 1.116-EXPEDITED PROCEDURE EXAMINING

GROUP A877

The Fee has been calculated as shown below:

CLAIMS	CLAIMS REMAINING		HIGHEST NUMBER PREVIOUSLY PAID	NO. EXTRA CLAIMS	RATE	CALCULATIONS
TOTAL	9	MINUS	20	0	× \$18 =	\$0.00
INDEPENDENT	4	MINUS	7	0	× \$84 =	\$0.00
		□ MUL′	TIPLE DEPENDENT	CLAIMS	+ \$280 =	\$0.00
			TOTAL OF A	BOVE CALCU	JLATIONS	\$0.00
	□ Reduction by 50% for filing by Small Entity				\$0.00	
		□ Recor	dation of Assignment		+ \$40 =	\$0.00
					TOTAL	\$0.00

☐ A check in the amount of

is attached.

- Please charge any additional Fees for the papers being filed herewith and for which no check is enclosed herewith, or credit any overpayment to deposit Account No. 15-0030. A duplicate copy of this sheet is enclosed.
- If these papers are not considered timely filed by the Patent and Trademark Office, then a petition is hereby made under 37 C.F.R. §1.136, and any additional fees required under 37 C.F.R. §1.136 for any necessary extension of time may be charged to Deposit Account No. 15-0030. A duplicate copy of this sheet is enclosed.

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GJM:RTP:KDP:brf I:\atty\kdp\19's\192520US2\Amend Cvr.wpd 192520US2

"RESPONSE UNDER 37 CFR 1.116-EXPEDITED PROCEDURE EXAMINING

GROUP_ 2877

IN THE UNITED STATES PATENT & TRADEMARK OFFICE

IN RE APPLICATION OF:

Hayashi OTSUKI, et al.

: GROUP ART UNIT: 2877

SERIAL NO: 09/594,479

FILED: JUNE 14, 2000

: EXAMINER: PUNNOOSE, R.

FOR: PARTICLE-MEASURING

SYSTEM AND PARTICLE-MEASURING METHOD

AMENDMENT AFTER FINAL

ASSISTANT COMMISSIONER FOR PATENTS WASHINGTON, D.C. 20231

SIR:

In response to the Official Action dated April 24, 2002, reconsideration of the aboveidentified application is respectfully requested in view of the following amendments and remarks.

IN THE CLAIMS

Please cancel Claims 1-8 and 18-20 without prejudice or disclaimer.

REMARKS

Favorable reconsideration of this application as amended, and in light of the following

discussion is respectfully requested.

O.K to GNTER 28/00/02